

In Place of FORM PTO-1449 (Modified)

Serial No. 10/670,824

**LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE
STATEMENT**

Applicant: Brokenshire

Filing Date: 9/25/2003

Group: 2191

Atty. Docket No. AUS920030702US1

U. S. PATENT DOCUMENTS

Examiner <u>Initial</u> <u>/PN/</u>		Document <u>Number</u>	<u>Date</u>	<u>Name</u>	Classification <u>Class / Subclass</u>	Filing Date if <u>Appropriate</u>
	AA	5,359,721	10-1994	Kempf et al.	719/331	
	AB	2003/0188045	10-2003	Jacobson	710/1	
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					

FOREIGN PATENT DOCUMENTS

Examiner <u>Initial</u>		Document <u>Number</u>	<u>Date</u>	<u>Country</u>	Classification	Translation <u>Yes No</u>
	AK					
	AL					

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner <u>Initial</u>	
	AM
	AN
	AO
	AP

Examiner: /Phillip Nguyen/

Date Considered: 02/04/2008

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<u>/PN/</u>	AA	4,945,479	07-1990	Rusterholz et al.	712/3	
<u>/PN/</u>	AB	6,542,926	04-2003	Zalewski et al.	709/213	
<u>/PN/</u>	AC	6,195,676	02-2001	Spix et al.	718/107	
<u>/PN/</u>	AD	5,179,702	01-1993	Spix et al.	718/102	
<u>/PN/</u>	AE	7,103,664	09-2006	Novaes et al.	709/226	
<u>/PN/</u>	AF	5,649,184	07-1997	Hayashi et al.	707/8	
<u>/PN/</u>	AG	7,165,108	01-2007	Matena et al.	709/226	
<u>/PN/</u>	AH	6,578,068	06-2003	Bowman-Amuah	709/203	
<u>/PN/</u>	AI	7,210,148	04-2007	Arnold et al.	719/330	
<u>/PN/</u>	AJ	7,137,115	11-2006	Sakamoto et al.	718/102	
<u>/PN/</u>	AK	6,728,961	04-2004	Velasco	718/105	
<u>/PN/</u>	AL	6,950,848	09-2005	Yousefi'zadeh	709/203	
<u>/PN/</u>	AM	7,062,768	06-2006	Kubo et al.	718/105	
<u>/PN/</u>	AN	6,292,822	09-2001	Hardwick	718/105	
<u>/PN/</u>	AO	6,981,074	12-2005	Oner et al.	710/32	
<u>/PN/</u>	AP	7,093,258	08-2006	Miller et al.	718/105	
<u>/PN/</u>	AQ	6,684,390	01-2004	Goff	717/148	
<u>/PN/</u>	AR	6,199,179	03-2001	Kauffman et al.	714/26	
<u>/PN/</u>	AS	5,812,843	09-1998	Yamazaki et al.	718/100	

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	AT					
	AU					

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner <u>Initial</u>		
<u>/PN/</u>	AV	IBM Dictionary of Computing, George McDaniel, 1994, page 692.
	AW	

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